

The 8th International Conference on Micro-Pattern Gaseous Detectors Oct.14th - Oct.18th 2024 USTC Hefei, China

Technical challenges for the new T2K High Angle TPCs

17 October 2024

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on behalf of the T2K ND280 upgrade group

The 8th International Conference on Micro-Pattern Gaseous Detectors | Oct.14th - Oct.18th 2024 USTC·Hefei, China | S. Levorato

Outlook

- **The T2K ND280 experiment**
- **The ND280 upgrade project**
	- The motivations
	- The upgrade
- **The High Angle Time Projection Chambers (HATPC)**
	- A short detector description
- **The Encapsulated Resistive Anode Micromegas (ERAM)**
	- Construction
	- Quality assessment
	- Performance
- **Conclusions**

17.10.2023 MPGD 2024 | Oct.14th - Oct.18th 2024 USTC·Hefei, China | S. Levorato 2

The T2K experiment and the role of ND280

Precise measurement of ν_{μ} disappearance $\rightarrow \theta_{23}$ and $|\Delta m^2_{32}|$

Several detectors installed to monitor the beam reduce systematic uncertainties in oscillation analyses, and measure ν and $\bar{\nu}$ crosssections

ND to measure un-oscillated beam flux and v cross sections

The ND280 experiment: the upgrade

momentum (MeV)

Muons in TPC or

stopping in SuperFGD

nol

ND280: the upgrade detectors

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ND280: upgrade completed! Top-HATPC installed in the end of April 2024

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The ND280 experiment: High Angle TPC highlights

- The HATPC detector
	- A short introduction
- Encapsulated Resistive Anode Micromegas (ERAMs)
	- The realization of the 50 ERAM sensors
	- The ERAM characterization
	- Detector response, signal
- HATPC performance

The ND280 experiment: HATPC requirements

Momentum resolution $\sigma_{\text{p}}/\text{p} < 9\%$ at 1GeV/c (neutrino energy)

Energy resolution $\sigma_{\text{dE/dx}}$ < 10% (PID muons and electrons)

Space resolution $O(500 \mu m)$ (3D tracking & pattern recognition)

Low material budget walls \sim 3% X_0 (matching tracks from neutrino active target)

- ⚫ Low material budget, thin walls
- Active volume $\sim O(3m^3)$

Resistive MicroMegas sensors (ERAMs)

- Overall anode active surface $\sim O(3m^2)$
- \sim Sampling length \sim 80-160 cm
- \cdot pads \sim 1x1cm²
- 17.10.2023 MPGD 2024 | Oct.14th 10k+10k channels / TPC @ End Plates (Anodes) | 9

HATPC, an overview on the main elements

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ERAM: MicroMegas with DLC resistive foil

Resistive layer enables charge spreading \rightarrow space resolution below 500 μ m with larger pads

- \rightarrow less FEE channels (lower cost)
- \rightarrow improved resolution at small drift distance (where transverse diffusion cannot help)

Resistive layer prevents charge build-up and quench sparks

- \rightarrow enables operation at higher gain
- \rightarrow no need for spark protection circuits for ASICs
	- \rightarrow compact FEE \rightarrow max active volume

Resistive layer encapsulated and properly insulated from GND

- \rightarrow Mesh at ground and Resistive layer at $+HV$
- \rightarrow improved field homogeneity \rightarrow reduced track distortions
- \rightarrow better shielding from mesh and DLC \rightarrow potentially better S/N

ERAM Module breakout

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Charge spread on *low* **resistivity foil**

ERAM production ~ 50 detectors

DLC layer: foil selection, QC

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ERAM Series production experience: X-ray scan

X-rays Test Bench at CERN fundamental to

- 1) Qualify, characterize and calibrate all prototypes and series ERAMs
- 2) Support the development of detailed ERAM response model

A) Mesh Pulsing: before and after stiffener gluing **Aim**: detector geom defects (i.e. pillar detach), stiffener gluing issues, electronic noise

B) X-ray scan of finalized detectors with final electronic modules. Remote controlled station for scanning with mm step fine steps

Aim: QC and fine calibration in terms of gain, resolution and RC

ERAM Series production experience: X-ray scan

17.10.2023 1 am mesh-DLC gap variation => 10% variation in gain a S. Levorato 1

ERAM Series production experience: X-ray scan the importance of the (fast) QA

Gain maps of eight ERAMs tested together in a field cage prototype

A map of gain non-uniformity within a pad. relative shift of the mean amplitude reconstructed in the top, bottom, left or right region of each pad under study w.r.t mean amplitude of the pad

DLC pressing on the PCB during detector assembly resulting in the non-uniformities observed on the 2D gain and energy resolution maps \rightarrow The solder mask is removed and replaced by the copper mesh.

ERAM Series production: a summary table

ERAM Assembly and Operation experience

Low resistivity DLC $O(\sim 500 \text{k}\Omega/\text{m})$ [after annealing] features

- Optimal charge spread \rightarrow uniform response across pad (combined with $C \sim O(20pF/cm^2)$
- Fast Q removal and Effective Protection against sparks included at moderate rates \sim O(1kHz) tracks crossing pads
- Leakage currents at level of few nA in normal conditions (no beam)

ERAM @ test beam 2022

Challenging installation conditions

ERAM assembly (and storage) in Clean Room

Grey tent area in front of Clean

Noise: stability of the installed detector

Noise in module 0 has been stable between September 23 and June 24

All the Erams are quasi-identical but one, Eram 27, due its higher capacitance

 \rightarrow the excellent uniformity of the electronics and of the mechanical definition of the glue layer driving the detector capacitance

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ERAM detector response – Noise model

Previous conclusions supported by the noise detailed model included in the MC for Simulation of charge deposition in events

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The ND280 experiment: High Angle TPC highlights

How does the signal look ? Point deposition for example

Leading pad: highest and earliest signal

⇒ current induced on pads from by avalanche, ie **ions** signal (as electrons' signal is too fast) Adjacent pads: lower and later signals ⇒ current induced by potential field adjustments after **electrons** are collected by on DLC (current induction by "charge spread on resistive layer")

time bins (40ns)

Reconstruction of charge deposition 1/2

Electronics

Within our electronics shaping time scale in primary pads, the signal of ions is *diluted* by the signal of charge spreading => Need to combine information of all pads (primary and secondary)

Reconstruction of charge deposition 2/2

Charge on DLC spreads along any direction including track direction «**longitudinal correlation**» across primary pads within our electronics shaping time scale

requires a dedicated signal formation model

ERAM response – Signal formation model

ERAM response – Signal formation model

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ERAM detector response: impact on reconstruction

Use of the model for Reconstructing the charge deposition

Due to square shape of ERAM pads, the classical method (PRF+clustering) works OK only for tracks with horizontal or vertical direction (wrt pads coordinates)

Better methods use solutions of telegraph equation in order to

- 1) compute the pattern templates for charge diffusion on DLC
- 2) calculate the overall expected signal waveform per each pad
- 3) find the best matching with the recorded waveforms

Its computationally heavy \rightarrow different approximations are used for different analysis

- 1) X-rays analysis ERAM characterization
- 2) Measurement of dE/dx Particle Identification
- 3) Track reconstruction momentum measurement

Reconstructing X-rays charge deposition

 $Q_{pad}(t)$ = Solution of 2D Teq. for diffusion of initial Q deposited charge (point-like, delta-pulse initial conditions)

 $RC = 60$ ns/mm²

 $Q_{\circ} = 4 e^{t}$

$$
Q_{pad}(t) = \frac{Q_e}{4} \times \left[erf(\frac{x_{high} - x_0}{\sqrt{2}\sigma(t)}) - erf(\frac{x_{low} - x_0}{\sqrt{2}\sigma(t)}) \right] \times \left[erf(\frac{y_{high} - y_0}{\sqrt{2}\sigma(t)}) - erf(\frac{y_{low} - y_0}{\sqrt{2}\sigma(t)}) \right]
$$

- $\sigma(t) = \sqrt{\frac{2t}{RC}}$ \geq Obtained from Telegrapher's equation for charge diffusion.
- Integrating charge density function over area of 1 readout pad.
- \triangleright Parameterized by 5 variables:
	- Initial charge position $\cdot y_0$
	- \cdot t_o: Time of charge deposition in leading pad
	- RC : Describes charge spreading
	- Q : Total charge deposited in an event

 x_{μ} , x_{μ} : Upper and lower bound of a pad in x-direction y_{μ} , y_{μ} : Upper and lower bound of a pad in y-direction

Reconstructing X-rays charge deposition WF templates

Extraction of RC and Gain maps from X-rays

Converted X-ray impact point position is also fitted →**accurate maps of Gain and RC**

Use for detailed studies of charge diffusion and ERAM response at fine PAD position level

Indications are that the **lower resistivity** the **better the performance** (eg space resolution)

Reconstructing Q along tracks

For the reconstruction of the charge along the tracks two methods

- **Waveform Sum (WS)**
- **Crossed Pad (XP)**

Compare the performance of the two methods for dE/dx extraction

Reconstructing Q along tracks: Waveform Sum

Reconstructing Q along tracks: Crossed Pad (XP)

- 1) Reconstruct tracks and consider only pads crossed (XP) by the track (primary pads)
- 2) Reconstruct original (ion induced) charge (Q) for each XP (given the track parameters there)
	- by Q = A x (Q/A) where A is recorded amplitude on XP and rescaling ratio (Q/A) from Look Up tables (LUT)

LUTs build from model: original Q is distributed linearly over the segment for each XP so that solutions of diffusion equations can be used

1) No clustering => potentially more accurate method because reconstructing full induced charge on primary pads 2) «dilution of ion signal» on a XP pad, due to charge spread over the pad is correctly taken into account 3) «longitudinal correlation» among adjacent XP pads, due to charge spread along track direction is accounted for

4) Fast method though based on model templates (long time is to generate LUTs ...)

Reconstructing Q along tracks: Crossed Pad (XP)

dE/dx preliminary results: (WS) and (XP) methods

dE/dx preliminary results: (XP) method

Bethe-Bloch for different particles

PID preliminary results (XP) vs (WS)

e/μ separation @ 1.5 GeV – Test Beam data (CERN PS T10)

Short tracks (~40cm) Short tracks (~160cm)

Reconstructing tracks

For the reconstruction of the tracks

Log(Q) methods

Full Waveform fit Method

Reconstructing tracks, trajectory fitting: an example

Spatial resolution: the importance of the QA

Top HAT was equipped with ERAMs with larger RC variation w.r.t. Bottom

High RC → less charge spreading "flatter curve" Low RC → more charge spreading

"steeper curve"

dX: distance from the center of the cluster and the real position

Non negligible RC variation among the same Endplate of the TPC

Need to tune the log(Q) parametrization \rightarrow ERAM dependent....

Spatial resolution after reparameterization

Reconstructing tracks: momentum resolution

 $\sigma_{\rm p}$ /p momentum resolution as a function of track drift distance: simulated 700 MeV/c muons

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Event display, full ND280 detector!

Conclusions

Two new TPCs have been just installed in ND280 at JPARC

- Very stable operations in commissioning and technical runs
- Firs Neutrino Data taking just completed, restarting now !

Resistive MM with encapsulated anode **ERAM**

- First time use of an encapsulated resistive Micromegas in a High Energy running experiment
- Low resistivity & optimal charge spread & no sparks effects
- Series production allowed several detailed studies
- The ERAM technology is complex and delicate to produce as are all the resistive MPGDs. The expertise and excellent partnership with the CERN/PCB workshop enabled a high yield (~80%) of high-quality production
- New algorithms for square pads exploiting detailed response model under development
- Detector performance, still preliminary but very promising!

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Trans.

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Just in Case

- ▶ The goal of Long Baseline neutrino experiments:
- \checkmark Remaining problems: CP symmetry, Mass ordering, Octant of θ_{23}
- \checkmark Precise measurements of θ_{23} , $|\Delta m^2_{31}|$ $(\sim |\Delta m^2_{32}|)$

$$
\begin{aligned}\n\text{\textcolor{red}{\blacklozenge M}non neutrino disappearance (\nu_{\mu} \rightarrow \nu_{\mu}) :} \\
P(\nu_{\mu} \rightarrow \nu_{\mu}) \approx 1 - \left(\cos^2\theta_{13}\sin^22\theta_{23}\right)\sin^2\left(\Delta m_{32}^2 \frac{L}{4E_{\nu}}\right) \left[\theta_{23}, \left|\Delta m_{31}^2\right| \left(\sim \left|\Delta m_{32}^2\right|\right)\right]\n\end{aligned}
$$

Electron neutrino appearance $(\nu_{\mu} \rightarrow \nu_{e})$ **:**

$$
P(\nu_{\mu}\to\nu_{e})\approx\sin^{2}\theta_{23}\sin^{2}2\theta_{13}\sin^{2}\left(\frac{\Delta m_{32}^{2}L}{4E_{\nu}}\right)\left(1+\frac{2a}{\Delta m_{31}^{2}}\left(1-2\sin^{2}\theta_{13}\right)\right)\overbrace{\left.\begin{array}{l} \text{Sensitive to:}\\ \theta_{13},\,\delta_{CP},\,\theta_{23},\,\text{and}\\ \theta_{13},\,\delta_{CP},\,\theta_{23},\,\text{and}\\ \text{Mass ordering }\Delta m_{31}^{2}\end{array}\right.}
$$

 $\triangle P(\bar{\nu}_{\mu} \rightarrow \bar{\nu}_{e})$: δ turns into – δ and a to -a ("a" matter effect term)

Reconstructing tracks: trajectory fitting

- logQ method to reconstruct position in each cluster
- Helix fit performed on those reconstructed positions

Full Waveform fit Method – based on model & no clustering

1) Use all the pads associated to a track (Qmax values) to define a (v,u) local frame

- 2) Distribute "arbitrary" point charges along v axis separated by Δv (5mm) the Q per each point is a free parameter
- 3) Diffusion model to predict the waveform generated by point charges in surrounding pads

Figure 28: Comparison of gain extracted using the waveform sum and simultaneous fit methods for all the analyzed ERAMs.

Figure 37: Effect of T/P on the gain of one pad. The lowest value of (T,P) recorded during the scan was (19.8 °C, 959.5 mbar) and the highest value was (24.5 °C, 963.7 mbar).

Figure 29: Dependence of mean RC on mean gain of all the analyzed ERAMs.

Figure 30: Left: 2D map of the relative gain in ADC of the ERAM-10 module; Middle: 2D map of the energy resolution in % of the ERAM-10 module; Right: PCB top layer: the grey area are 20-35 $\mu \mathrm{m}$ thick copper $+$ 50 $\mu \mathrm{m}$ soldermask while the cross hatched area is made of conner mesh only

Detailed R measurement (dedicated probe)

A dedicated probe has been built to perform a fine measurement of the surface resistivity.

Will be soon complemented with the comparison with the data extracted from X-ray analysis

R **inhomogeneities** in the sputtering are clearly visible in the direction perpendicular to the drum rotation axis.

Comparaison of averages over all erams of a module

- The term $\overline{6.1}$, identified as the low-frequency fitting of the deterministic contribution (Section 5.3.4, Fig. $\overline{5.6}$). The form of the equation ensures that the mean is 0. Additionally, A_{max} controls the maximum amplitude, and t_{max} determines its position.
- The term $\boxed{6.2}$, represents the high-frequency adjustment of the deterministic contribution (Section 5.3.5, Fig. 5.6) is represented by a simple $cos(f_n)$ with a frequency of $\frac{f_i}{4}$. The amplitude is adjusted using the parameter A.

$$
S(t_b) = A_{\max} \left(1 - \frac{\pi}{2} \left| \sin \left(\frac{\pi (t_b - t_{\max})}{t_w} \right) \right| \right)
$$

+ $A \cos \left(2\pi \frac{f_s}{4} t_b + \pi \right)$
+ $\sum_{f} I(f) |H(i2\pi f)| \cos (\omega t_b + \phi_H + \phi_R)$
+ $\mathcal{N}(0, \sigma)$ (6.4)

• The term $\overline{6.3}$, describe the AFTER chip contribution (Section 5.2), which is the response of the electronics to the random current:

$$
I(t) = \sum_{f} I(f) \cos(\omega t + \phi_{\mathbf{R}})
$$

because for a signal such as :

 $I(t) = I_0 \cos(\omega t)$

the electronic response is by definition of the Transfer Function:

 $S_{elx}(t) = I_0 |H(i2\pi f)| \cos(\omega t + \phi_H)$

where $|H(s = i2\pi f)|$ and Φ_H are the norm and the phase of the transfer function (cf Fig. 3.2).

• The term $\overline{6.4}$, we refer to the white noise (Section 5.4), which is represented by Gaussian distribution added for each time bin

Mean waveforms, averaged over events and erams

Figure 5.3: Mean waveforms of few pads in the ERAMs, averages over all events

As is clear from the Fig. 5.3 , there is two typologies of the mean waveform. It has been shown that these two types correspond to two populations of pads positioned on the ERAMs as shown on Fig. 5.4.

Conclusions

Two new TPCs have been just installed in ND280 at JPARC

- Very stable operations in commissioning and technical runs
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Field cages

- High ratio active/passive volume
- Highly effective insulation & E field uniformity
- Composite material technology exploited at the limit of the technology

Resistive MM with encapsulated anode

- Low resistivity & optimal charge spread & no sparks effects
- Series production allowed several detailed studies
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HATPC: features, challenges, constrains and solutions

Mechanics and Electric Field uniformity

• Min dead space & max active volume in the dipole magnet

→Rectangular shape & thinnest walls & field shaping electrodes incorporated

- into the walls
- Electric field uniformity better than 10^{-3} @1cm from walls
	- \rightarrow Mechanical accuracy: inner surfaces planarity & parallelism \sim O(0.2mm/m)
	- → Shaping Electrode design: Field and Mirror copper strip layers on two sides
- of a Kapton foil
- Low material budget walls
	- \rightarrow lightweight & lowest Z & robust (self supporting)

Electrical insulation Constrains

• HV insulation mantle R > 1TOhm and volume resistivity, HV

→geometry: several cm paths for charge from -HV strips to GND shielding (cathode flanges)

 \rightarrow insulating materials: very high resistivity & dielectric strength

HATPC: features, challenges, constrains and solutions

Building process: hand lay-up of composite materials on a Mould & polymerization in autoclave at high Pressure

• Autoclave dimensions

 \rightarrow Field Cage comprising two halves (symmetrical flanges at central cathode position)

• Hand layup & large dimensions

 \rightarrow several hours per process step \rightarrow very long pot life for epoxy resin

• Mechanical accuracy of geometry \rightarrow resin curing at low T < $O(40^{\circ}C)$

Materials of choice

- lamination materials: Aramid polymers for peels (Twaron) and for honeycomb (Nomex paper)
- epoxy resin limited choice: Resoltech 1054 combined with quality control against contaminants (moisture, …)
- high insulation layers: Kapton
- box skeleton material: high quality laminated G10

The ND280 experiment: High Angle TPC highlights

- Field Cage (FC)
	- Assembly and layout
	- **Production**
	- Characterization and Quality Assessment
		- **Mechanical**
		- **Electrical**
	- Encapsulated Resistive Anode Micromegas (ERAMS)
		- Production of 50 sensors
		- **Characterization**
		- Detector response, signal and impact on reconstruction
- Impact on HATPC performance

Field cage mechanical details: charge path to gnd

Flange thickness (5cm) too small for degrading -30kV to GND over a flat surface

Three deep grooves

for extending the path from HV to GND for charge moving on surface and with gas flanges

- ~ 7cm thick labirinth
- ~14 cm path lenght

 \rightarrow voltage drop / path length < 3kV/cm

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Field Cage building, assembling and characterization

Field Cage building, assembling & characterization at NEXUS Kapton Layer

Production at NEXUS company (Barcelona) ~ 10 weeks Validation, QC, electrical and mechanical assembly at CERN ~ 4 weeks

5 m perimeter x 1m height (drift length)

• Electrical tests on surfaces • Resin samples electrical Tests

- **Mold preparation**
- Inner Vacuum bag
- **Strip Foil positioning Thick corners w/ Kapton tape**

- Kapton lamination
- Curing at 40C (fast)
- Electrical tests on surfaces and resin samples after curing

Field Cage building, assembling & characterization at NEXUS Kapton Layer and inner Twaron

Inner Twaron peel lamination

- **First Twaron layer lamination**
- Curing at 40C (fast) in autoclave

Electrical tests

- Resin sample

Quality controls – Resistivity of early Layers

1) Resistance between mold and 40x45cm2 electrode -> volume resistivity of layers

3) Resistance between two 6x80cm2 electrodes -> mix of surface and volume resistivity

2) Surface resistivity of last layer Twaron

- 1) various methods and electrode types (optimizing contact) \rightarrow consistent measurements
- 2) Resin sample $\rho_s \sim 10 \text{ T}\Omega/\square$

Field Cage building, assembling & characterization at NEXUS Kapton Layer + inner Twaron + G10 Skeleton

Cotton

- G10 skeleton gluing
- Curing 40C in clean room

Gluing G10 "skeleton"

Gluing G10 structural skeleton and casting resin on flanges for ensuring gas tightness

- Casting low viscosity resin on top flange \rightarrow sealing flange to laminated layers
- Autoclave curing at 40C

(TV, Italy)

Field Cage building, assembling & characterization at NEXUS Kapton Layer + inner Twaron + G10 Skeleton + HC + Ext Twaron

- Gluing Nomex Honeycomb
- Curing at 40C in oven

- Flipping the box top-bottom
- Resin casting on second flange
- Curing at 40C in autoclave
- **Second Twaron peel lamination**
- Curing at 40C in autoclave

Outer Twaron peel lamination

Post-curing at 40C in oven (lasting as long as possible)

Field Cage machining and final QC at Nexus

- Back to NEXUS company for
- Mould removal
- Very fine polishing of flanges
- Correction of defects (eg bubbles)

machining of cathode and anode flanges and surfaces finishing

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Field Cage assembling, characterization at CERN

Vertical assembly of two Field Cages into HATPC

INF

Cathode assembly

Cathode assembly

Connection of last strips to cathode

High Voltage feedtrough external connection

High voltage tests after assembly

Field Cage assembling, characterization at CERN

- 1) He leak tested sniffer (air + 30mbar of He)
- 2) Tested against gas density changes
- He Over-pressure (+20mbar)
- Air Under-pressure (-20mbar)

Gas leakages qualification

985

984

[mbar]
Field Cage assembling, characterization at CERN

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Field Cage assembling, characterization at CERN

Mechanical qualification

Comparison with FEM models in fair agreement with

- load tests
- deformation vs pressure

Field Cage assembling, metrology at Nexus

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Field Cage assembling, metrology at CERN

17.10.2023 MPGD 2024 | Oct.14th - Oct.18th $300\mu m$ with few localized, acceptable exceptions

Field Cage assembling, ERAM installation

Assembly the 16 ERAMs in Clean room for each TPC

Grey tent area in front of Clean Room large entrance for enhanced clean conditions

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Field Cage assembling, commissioning with cosmics

Projection on Anode End Plate 1

TZKI

TINEN

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Field Cage assembling, commissioning: gas contamination at CERN

Field Cage assembling, commissioning: gas contamination at J-PARC

Field Cage assembling, commissioning: drift velocity measurement

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TPC

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Near Detector impact on Oscillation Analysis

- ND280 magnetized detector
- Select interactions in FGD and measure muon kinematics in the **TPCs**
- Separate samples based on number of reconstructed pions ($CC0\pi$, $CC1\pi$, $CCN\pi$), protons, photons, etc
- Factor of ~3 reduction on the uncertainty on the event rates at the Far Detector

(e) \overline{v} -mode 1Re

(d) \overline{v} -mode 1Ru

ND280 limitations

- Improve angular acceptance ν
- Better reconstruction and usage of the hadronic part of the interactions!
	- Currently samples are selected according to their topology (0π , 1π , $1p$, $N\pi$, ...) but the kinematics of the hadrons is not used in any way in the constraint on flux and x-sec systematics \rightarrow plenty of additional information to be exploited
	- This is due to both, a low efficiency from ND280 to reconstruct hadrons and the difficulties in modeling the x-sec systematics for the hadronic part
		- With the upgrade we plan to improve the efficiency to reconstruct hadronic part

ND280 Upgrade improvements

- High-Angle TPCs allow to reconstruct muons at any angle with respect to beam
- Super-FGD allow to fully reconstruct in 3D the tracks issued by ν $interactions$ \rightarrow lower threshold and excellent resolution to reconstruct protons at any angle
	- Improved PID performances thanks to the high granularity and light yield
- Neutrons will also be reconstructed by using time of flight between vertex of $\bar{\nu}$ interaction and the neutron re-interaction in the detector

Protons \rightarrow threshold down to 300 MeV/c

Mantle resistance

Figura 4.2: Spostamento lungo R del punto di arrivo di un elettrone causato da una resistenza R_{man} di un mantello isolante mille volte il valore della catena di resistori R. La distorsione é mostrata come funzione del punto di partenza z (Distanza dall'anodo).

ERAM Production - about 50 detectors

Field Cage assembling, characterization at CERN

Gas contamination from Field Cage – other **contaminants**

- H2O (+ HO) contamination $\sim 2\% \rightarrow c_0$ nsistent with other sensors (Vaisala)
- O2 peak below sensitivity \rightarrow consistent with ppm level \rightarrow need further checks

No HF acid a parently (below Ar++)

LON

Analysis of gas composition during cosmics test in May

- **HCl** acid
- Evolution in time of components

ERAM Series Production experience

Effect of gas density on (gas)

Effect of humidity on (gas)

GAIN

Reconstructing tracks dE/dx

dE/dx – comparison of SWF and XP methods on Test Beam data (4GeV electrons, DESY)

- Very good agreement overall
- Better resolution with XP with diagonal п tracks

- Disagreement at small drift distance: reflects the п track fitting quality
- Disagreement for Y scan: taken at small drift distance
- Disagreement for diagonal tracks: using only on ٠ correction function for WF_{sum} is not suitable

Reconstructing tracks – pattern recognition

- Time and charge definition for each hit
- Waveform multipeak search in order to differentiate vertices and crossing trajectories
- Merging between different ERAMs and End Plates

Reconstructing tracks – trajectory fitting

T2K gas properties

T2K gas

Just in Case

17.10.2023 MPGD 2024 | Oct.14th - Oct.18th 2024 USTC·Hefei, China | S. Levorato 98

Figure 31: A map of gain non-uniformit shift of the mean amplitude reconstruct pad under study with respect to the me

sooonaa ayoo

Figure 32: Schematic view of the DLC resulting in the non-uniformities observ The arrows represent the mechanical when the soldermask is removed and rea

 (c)

T1 - T2

D

A1

Figure 23: Comparing the features of an RC map (a) with the maps of two different basic-level variables (b) and (c) for ERAM-16. Variables var1 and var2 described in plot (d) are used to⁷donstituct the maps/(ODand24(c) respectively 8th 2024 USTC·Hefei, China | S. Levorato 99/20

Figure 23: Comparing the features of an RC map (a) with the maps of two different basic-level variables (b) and (c) for ERAM-16. Variables var1 and var2 described in plot (d) are used to construct the maps (b) and (c) respectively.

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Figure 35: Effect of T/P on gain of an ERAM. The top and bottom x-axes represent the timelines of the two full detector scans.

Figure 36: Effect of relative humidity on gain of an ERAM. The top and bottom x -axes represent the timelines of the two full detector scans.

Table 7. Typical Electrical Properties of Kapton® Type HN and HPP-ST Films

Although a-C:H and ta-C belong to the same material family, they are not produced by the same coating process. a-C:H is achieved by PECVD (Plasma Enhanced Chemical Vapor deposition) in a gaseous environment. Whereas ta-C is produced by PVD-arc (Physical Vapor deposition arc) from a solid carbon target. PVD-arc technology enables the production of a ta-C coating with a higher percentage of sp3 hybridization without hydrogen and providing a higher hardness.

• Thermal annealing of ta-C is well known

- \bullet a-C:H as well. But.
- "Thermal annealing of a-C:H also reduces the stress, as in ta-C. However, as the bonding in a-C:H is less stable during annealing, annealing is less useful in this case."
- Mechanism described
	- Thermal annealing converts a small fraction of sp^3 (2%) to sp^2
		- Distance between atoms is different between sp² and sp³
		- New sp² structure has aligned electron orbitals
	- The conversion causes exponential decrease in resistivity
	- Compressive stress relieved by new sp² structure with electron orbitals aligned

 ∞ π orbital σ orbita

S. Ban^A, W. Li^A, A. Ochi^B, W. Ootani^A, A. Oya^A, H. Suzuki^B, M. Takahashi^B (^{AThe University of Tokyo, ^BKobe University)}

A breakdown of the resistive layer means creating a low Ohmic channel in the layer

T2K+SK joint analysis

- T2K has good sensitivity to δ_{CP} but mild sensitivity to mass ordering
- SK has good constraint on mass ordering but not on δ_{CP}
- Adding SK atmospheric sample allows to break the degeneracies between the CP violation parameter δ_{CP} and the mass ordering \rightarrow boost sensitivity to CP

Mass ordering and θ_{23} octant

- Slight preference for normal ordering and upper octant but none of them is significative
	- Bayes factor NO/IO = 3.3
	- Bayes factor $(\theta_{23} > 0.5)/(\theta_{23} < 0.5) = 2.6$

T2K

Both experiments individually prefer normal ordering and δCP~ π/2, T2K prefers upper octant, SK prefer lower octant

We performed Bayesian and Frequentist analyses \rightarrow frequentist analyses shown today

The CP-conserving value of the Jarlskog invariant is excluded with a significance between 1.9 and 2 σ

- NOvA & T2K's first joint results: \bullet
	- Yield strong constraint on Δm^2_{32}
	- Weakly prefer IO or NO depending on which reactor constraint is applied
	- **Strongly favor CP violation in Inverted Ordering**
- $\frac{1}{24}$ Collaborations in active discussion about **joint fit next steps**

NOvA-T2K joint fit: takeaways

R inhomogeneities in the sputtering are clearly visible in the direction perpendicular to the drum rotation axis.

RC Map(ns/mm²) | ERAM30

 15

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 20

 25

 30 $\frac{35}{2}$ 135

130

125

120

110

105

 $\frac{8}{5}$ 30

ERAM49 - R $[k\Omega]$

 -90

 $-$ 85

 -80

 \times [cm]

30

 25

R inhomogeneities in the sputtering are clearly visible in the direction perpendicular to the drum rotation axis.

The ND280 experiment: High Angle TPC highlights

- Field Cage (FC)
	- Assembly and layout
	- **Production**
	- Characterization and Quality Assessment
		- **Mechanical**
		- **Electrical**

An outsider: Field C An outsider: Field Cage 0 ? • Characterization • Detector response, signal and impact on reconstruction **and learnt Electrical Issues, what we understood…**

Insulation issue in full scale FC0 prototype

Current drawn by voltage divider starting in large excess wrt nominal at power on and slowly decreasing to lower value but still in excess

Current drawn by voltage divider starting in large excess wrt nominal at power on and slowly decreasing to lower value but still in excess

Observed extra-currents in excess w. r. t. expected from voltage divider

 \sim

Insulation issue in full scale FC0 prototype

Innermost layers stack (first full-scale FC prototype)

Strip-Strip Potential difference of the strips @ 5kV

Voltage difference between Field strips (every 5 strips) ie V₁-V₂, V₅-V₆, V₁₀-V₁₁, ... V₁ = anode, V₁₉₆ = cathode

Measurement of Surface resistance of strip foil

(resistors removed)

Resistance between single strips is very high $O(T\Omega)$...but when joining some tens of strips to form a single large electrode then finite resistances are measured

Example: measured R ~15 GQ @ 1kV between two electrodes formed by 20Field+20Mirror strips each (surface of single electrode is huge ~ 0.5 m²) ! No voltage divider there, ie all strips disconnected

Resistance is

- Independent of the distance between electrodes

- Linearly dependent of the number of the strips \rightarrow not a surface resistance !

Measured R is rising with time (slow) up to saturation - when repeating measurement, go faster to saturation - when inverting polarity of electrodes, slow again \rightarrow looks like due to dielectric polarization / relaxation \rightarrow or capacitor charging trough high resistance

Find similar value of Resistance for same dimension electrodes formed in the Field Cage and on a strips foil Table 17.10: when aluminum foil is placed underneath the foil \rightarrow next $_{110}$

Buried resistive layer: a possible explanation

All observed features could be explained by the combination of two factors:

- 1) Presence of a resistive layer buried underneath the Kapton coverlay layer protecting the mirror Mirror strip
- 2) Low resistivity of the coverlay Kapton layer

Buried resistive layer: phenomenology

After applying HV after applying HV (eg -10kV) to the cathode, two phases:

1) Transient state: in time scale depending on the contaminated layers resistivity (in our case very short O(10s) time scale) the buried resistive layer become \sim equipotential (setting at intermediate potential -5kV) by drawing charge from the strips

2) Steady state: Mirror strips on the Anode, first half convey current to the buried layer, while mirror strips on the Cathode side draw currents from the buried layer

Buried resistive layer: phenomenology

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1) Transient state: in time scale depending on the contaminated layers resistivity (in our case very short O(10s) time scale) the buried resistive layer become ~ equipotential (setting at intermediate potential -5kV) by drawing charge from the strips

2) Steady state: Mirror strips on the Anode, first half convey current to the buried layer, while mirror strips on the Cathode side draw currents from the buried layer

Buried resistive layer: verification

In fact we **verified** the following

- Coverlay Kapton volume resistivity ~ 1G Ω cm much lower than datasheet)
- Twaron layer facing the coverlay featured surface resistivity ~ 1 G/ \Box

Both features could on turn be explained by the **accidental use of antistatic spray (resistive)** on the back of the strip foil (ie on the coverlay) after the strip foil was fixed on the Mould, in order to keep the huge foil surface (5m²) clean from dust and other possible contaminants. The spray contaminated both the Kapton coverlay (being very easily adsorbed) and the innermost layer of the Twaron (being mixed with the resin which impregnates the fiber fabric, during the Twaron lamination phase)

We could not exclude alternative sources of contamination affecting the resin and making it resistive (eg presence of water if epoxy not treated in vacuum after mixing)

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Buried resistive layer: electrical model

Buried resistive layer: electrical model results

Buried resistive layer: electrical model results

Buried resistive layer: fit to the data

Buried resistive layer: electrical model results

Final layout, materials and procedures fixed for the series production

- Minimize moisture trapped in wall layers: drying in oven Kapton & Twaron just before use
- QC epoxy contamination -> proper control of mixing and de-gassing process (new mixing / degassing tools and QC) and **… avoid antistatic spray…**
- QC electrical resistivity measurements after each early step in the production

ND280: installations at J-PARC

TOF installation (July 2023)

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Bottom TPC installation (September 2023)

Super-FGD installation (October 2023)

N280: commissioning at JPARC with cosmics

- **Detector** commissioning with and without magnetic field
- Alignment runs
- New software deployment
- New T2K gas system commissioning for both vertical and horizontal TPCs

N280: v technical runs in December 2023 and February 2024 physics run

INF

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The T2K run schedule: beam upgrade

n beam @ J-PARC: dedicated upgrade of the MR facility to reach the 1.3 MW beam power

Beam and Window Parameters

Expect to select 20k ^μ CC0pi interactions in the super-FGD for 0.2e21 POT (1 month)

December $2023 \rightarrow$ Beam power increased from 500 to 760 kW stable mode **800 kW** reached in 2024 for the first run with the fully upgraded ND280

Steady improvements to reach 1.3 MW by 2027 with an increase T2K statistics ~ a factor of 3 by 2027